FEATURES

- Wide Supply Voltage Range: 6...35V
- Wide Operating Temperature Range: -40°C...+85°C
- High Detection Sensitivity of Relative Capacitive Changes: 5% – 100%
- Detection Frequency up to 2kHz
- Adjustable Voltage Range: 0....5/10V, other
- Reference Voltage Source: 5V
- Protection against Reverse Polarity
- Output Current Limitation
- Adjustable with only two Resistors

APPLICATIONS

- Industrial Process Control
- Distance Measurement
- Pressure Measurement
- Humidity Measurement
- Level Control

BLOCK DIAGRAM

GENERAL DESCRIPTION

The CAV414 is an universal multipurpose interface for capacitive sensors and contains the complete signal processing unit on chip. The CAV414 detects the relative capacitive change of a measuring capacity to a fixed reference capacity. The IC is optimised for capacities in the wide range of 10pF to 2nF with possible changes of capacity of 5% to 100% of the reference capacity.

The voltage output is formed by a high accuracy instrumentation amplifier in combination with an operational amplifier.

With only a few external components, the CAV414 is suitable for a great variety of applications including a zero compensation.

DELIVERY

- DIL16 packages (samples)
- SO16(n) packages
- Dice on 5" blue foil

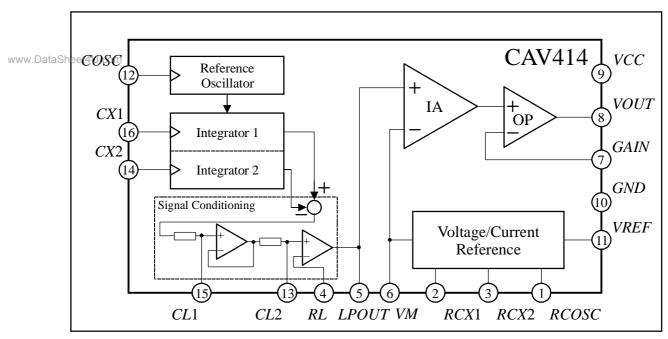


Figure 1

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ELECTRICAL SPECIFICATIONS

 $T_{amb} = 25^{\circ}$ C, $V_{CC} = 24$ V, $I_{REF} = 1$ mA (unless otherwise noted)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Supply						
Supply Voltage	V _{CC}		6		35	V
Quiescent Current	I _{CC}	$T_{amb} = -40 \dots 85^{\circ}\text{C}, I_{REF} = 0\text{mA}$		1.55	2.7	mA
Temperature Specifications						
Operating	Tamb		-40		85	°C
Storage	T_{st}		-55		125	°C
Junction	T_j				150	°C
Thermal Resistance	Θ_{ja}	DIL16 plastic package		70		°C/W
	Θ_{ja}	SO16 (n) plastic package		140		°C/W
Reference Oscillator	n			•	•	
Oscillator Capacitor Range	Cosc	$C_{OSC} = 1.6 \cdot C_{X1}$	14		1800	pF
Oscillator Frequency Range	fosc		1		130	kHz
Oscillator Current	Iosc	$R_{OSC} = 200 \mathrm{k}\Omega$	9.5	10	10.75	μΑ
Capacitive Integrator 1 and 2	1		1			
Capacitor Range 1	C_{X1}		10		1000	pF
Capacitive Integrator Current 1	I_{X1}	$R_{CX1} = 400 \mathrm{k}\Omega$	4.75	5	5.38	μA
Capacitor Detection Sensitivity	ΔC_X	$\Delta C_X = (C_{X2} - C_{X1})/C_{X1}$	5		100	%
Capacitor Range 2	С _{X2}	$C_{X2} = C_{X1} \cdot (1 + \Delta C_X)$	10.5		2000	pF
Capacitive Integrator Current 2	I _{X2}	$R_{CX2} = 400 \mathrm{k}\Omega$	4.75	5	5.38	μA
Detection Frequency	fdet	$C_{L1} = C_{L2} = \ln \mathbf{F}$			2	kHz
Lowpass	5000					
Adjustable Gain	G_{LP}		1		10	
Output Voltage	VLPOUT		$V_{M} - 0.4$		V_{M} +0.4	v
Corner Frequency 1	fc1	$R_{01} = 20 \mathrm{k}\Omega, C_{L1} = 1 \mathrm{nF}$			10	kHz
Corner Frequency 2	fc2	$R_{02} = 20\mathrm{k}\Omega, \ C_{L2} = 1\mathrm{nF}$			10	kHz
Resistive Load at PIN LPOUT	RLOAD		200			kΩ
Capacitive Load at PIN LPOUT	C_{LOAD}				50	pF
Temperature Coefficient V_{DIFF} (together with Input Stages)	$\mathrm{d}V_{DIFF}/\mathrm{d}T$	$V_{DIFF} = V_{LPOUT} - V_M,$ $T_{amb} = -40 \dots 85^{\circ}C$		±100		ppm/°C
Internal Resistor 1 and 2	R_{01}, R_{02}			20		kΩ
Temperature Coefficient $R_{01,02}$	$dR_{01,02}/dT$	$T_{amb} = -40 \dots 85^{\circ} C$		1.9		10 ⁻³ /°C
Power Supply Rejection Ratio (together with Input Stages)	PSRR	$I_{OUT} \le 1$ mA	80	90		dB
Voltage Reference V _{REF}	n			•	•	
Voltage	V _{REF}		4.75	5	5.25	V
Current	I _{REF}		0		9	mA
V_{REF} vs. Temperature	$\mathrm{d}V_{REF}/\mathrm{d}T$	$T_{amb} = -40+85^{\circ}C$		±90	±140	ppm/°C
Line Regulation	dV _{REF} /dV	Vcc = 6V35V		30	80	ppm/V
	$\mathrm{d}V_{REF}/\mathrm{d}V$	$Vcc = 6V35V, I_{REF} \approx 4mA$		60	150	ppm/V
Load Regulation	$\mathrm{d}V_{REF}/\mathrm{d}I$			0.05	0.10	%/mA
	$\mathrm{d}V_{REF}/\mathrm{d}I$	$I_{REF} \approx 4 \mathrm{mA}$		0.06	0.15	%/mA
Load Capacitance	C_{REF}		1.9	2.2	5.0	μF

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Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Voltage Reference V _M		·			•	n
Voltage	V_M		1.90	2	2.15	V
V_M vs. Temperature	$\mathrm{d}V_M/\mathrm{d}T$	$T_{amb} = -40+85^{\circ}C$		±90		ppm/°C
Current	I_{VM}	Source			5	μΑ
	I_{VM}	Sink			-5	μΑ
Load Capacitance	C_{VM}		80	100	120	nF
Instrumentation Amplifier Input St	age	·				
Internal Gain	G _{IA}		4.9	5	5.1	
Differential Range	V_{IN}		0		400	mV
Common Mode Input Range	CMIR	V_{CC} < 9V, I_{CV} < 2mA	1.5		<i>V_{CC}</i> - 3	v
	CMIR	$V_{CC} \ge 9 \text{V}, I_{CV} < 2 \text{mA}$	1.5		6.0	v
Common Mode Rejection Ratio	CMRR		80	90		dB
Power Supply Rejection Ratio	PSRR	$I_{OUT} \le 1 \mathrm{mA}$	80	90		dB
Offset Voltage	V_{OS}			±1.5	±6	mV
V _{OS} vs. Temperature	$\mathrm{d}V_{OS}$ / $\mathrm{d}T$			±5		$\mu V/^{\circ}C$
Output Stage		·				
Adjustable Gain	G_{OP}		1			
Input Range	IR	$V_{CC} < 11$ V	0		<i>V_{CC}</i> - 5	v
	IR	$V_{CC} \ge 11$ V	0		6	v
Power Supply Rejection Ratio	PSRR	$I_{OUT} \le 1 \mathrm{mA}$	80	90		dB
Offset Voltage	V_{OS}			±0.5	±2	mV
V_{OS} vs. Temperature	$\mathrm{d}V_{OS}/\mathrm{d}T$			±3	±7	$\mu V/^{\circ}C$
Input Bias Current	I_B			10	25	nA
I_B vs. Temperature	$\mathrm{d}I_B/\mathrm{d}T$			7	20	pA/°C
Output Voltage Range	Vout	$V_{CC} < 19 \mathrm{V}$	0		<i>V_{CC}</i> - 5	v
	Vout	$V_{CC} \ge 19$ V	0		14	v
Output Current Limitation	I _{LIM}	$V_{CC} \ge 10 \text{V}$	5	7	10	mA
Output Current	IOUT		0		ILIM	mA
Load Resistance	R_L		2			kΩ
Load Capacitance	C_L				500	nF
Protection Functions						
Protection Against Reverse Polarity		Ground vs. V _{CC} vs. V _{OUT}			35	V

Note:

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1) The oscillator capacity has to be chosen in the following way: $C_{OSC} = 1.6 \cdot C_{X1}$

2) The capacitor range of C_{X1} and C_{X2} can be extended whereby the system performance is reduced and the electrical limits are exceeded.

3) Currents flowing into the IC, are negative.

BOUNDARY CONDITIONS

Parameter	Symbol	Min.	Тур.	Max.	Unit
Current Definition of Ref. Oscillator	R _{COSC}	190	200	210	kΩ
Current Adjustment of Cap. Integrator 1	R _{CX1}	350	400	450	kΩ
Current Adjustment of Cap. Integrator 2	R _{CX2}	350	400	450	kΩ
Lowpass Stage Resistor Sum	$R_{L1} + R_{L2}$	90		200	kΩ
Output Stage Resistor Sum	$R_1 + R_2$	90		200	kΩ
Reference Voltage 5V	C_{REF}	1.9	2.2	5	μF
Reference Voltage 2V (only for internal use)	C_{VM}	80	100	120	nF
Lowpass Capacitance 1	C_{L1}	$100 \cdot C_{X1}$	$200 \cdot C_{X1}$		
Lowpass Capacitance 2	<i>CL</i> 2	$100 \cdot C_{X1}$	$200 \cdot C_{X1}$		
Oscillator Capacitance	Cosc	$C_{OSC} = 1.55 \cdot C_{X1}$	$C_{OSC} = 1.60 \cdot C_{X1}$	$C_{OSC} = 1.65 \cdot C_{X1}$	

Note: The system performance over temperature forces that the resistors R_{CX1} , R_{CX2} and R_{OSC} have the same temperature coefficient and a very close placement of them in the circuit. The capacities C_{X1} , C_{X2} and C_{OSC} are also forced to have the same temperature coefficient and a very close placement of them in the circuit.

FUNCTIONAL DIAGRAM

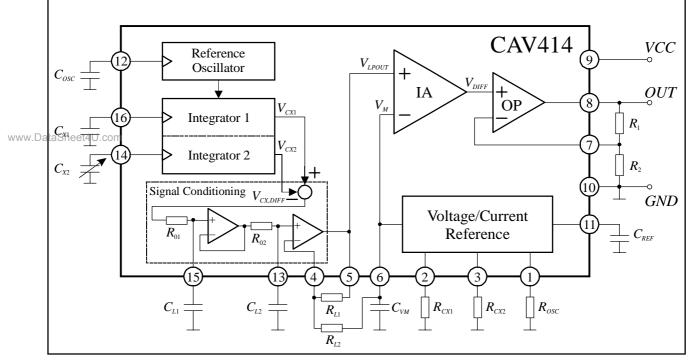


Figure 2

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FUNCTIONAL DESCRIPTION

A reference oscillator with a frequency adjusted by the capacity C_{OSC} drives two symmetrically built integrators synchronously to its clock and its phase. The capacitors C_{X1} and C_{X2} determine the amplitude of the two driven integrators. The difference of the integrator amplitudes gives the relative change of the capacities C_{X1} and C_{X2} to each other with high common mode rejection and high resolution. The difference signal is conditioned by a lowpass filter. The corner frequency and gain of it can be adjusted with a few external components. The output of the lowpass filter is connected to an instrumentation amplifier and an output stage. These two stages transform the signal into an adjustable voltage.

Adjustment:

The zero-adjustment is made by the resistors R_{CX1} or R_{CX2} for the case that the varying capacitance C_{X2} has nearly the same (and its smallest) value as the fixed capacitance C_{X1} (reference capacitance). Therefore one of this resistors is varied until the differential voltage

$$V_{DIFF} = V_{LPOUT} - V_{M}$$

is zero:

$$V_{DIFF} = 0$$

Application Example:

The following values are given:

- fixed capacitance C_{X1} : 50pF
- varying capacitance C_{X2} : 50 ... 100pF

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With the equations given in the boundary conditions, the following values for the devices can be calculated:

- *C*_{OSC}: 80pF
- C_{L1} : 10nF
- C_{L2} : 10nF

If the signal V_{DIFF} is amplified, it has to fulfil the unequation:

 $V_{DIFF} \le 400 \mathrm{mV}$

Detailed calculations are shown in a separately available Application Note.

CAV414

Converter IC for Capacitive Signals

PINOUT

RCOSC116 $CX1$ $RCX1$ 215 $CL1$ $RCX2$ 314 $CX2$ RL 413 $CL2$ $LPOUT$ 512 $COSC$ VM 611 $VREF$ $GAIN$ 710 GND $VOUT$ 89 VCC					
RCX1215 $CL1$ $RCX2$ 314 $CX2$ RL 413 $CL2$ $LPOUT$ 512 $COSC$ VM 611 $VREF$ $GAIN$ 710 GND					
$RCX2$ \square \square \square \square \square $RCX2$ \square 3 14 \square $CX2$ RL \square 4 13 \square $CL2$ $LPOUT$ \square 5 12 \square $COSC$ VM \square 6 11 $\lor REF$ $GAIN$ \square 7 10 \square GND	RCOSC	1	Ŭ	16	CX1
RL413 $CL2$ LPOUT512 $COSC$ VM611 $VREF$ GAIN710 GND	RCX1	2		15 🗌	CL1
$LPOUT \Box 5 12 \Box COSC VM \Box 6 11 \Box VREF GAIN \Box 7 10 \Box GND VI = 0 10 10 10 10 10 10 10 $	RCX2	3		14 🗌	CX2
VM \Box 611 $VREF$ $GAIN$ \Box 710 GND	RL 🗌	4		13 🗌	CL2
$GAIN \square 7 \qquad 10 \square GND$	LPOUT	5		12 🗌	COSC
	VM 🗌	6		11	VREF
$VOUT \square 8 \qquad 9 \square VCC$	GAIN 🗆	7		10 🗌	GND
	VOUT	8		9 🗆	VCC

PIN	NAME	DESIGNATION
1	RCOSC	Current Definition of Ref. Oscillator
2	RCX1	Current Adjustment of Cap. Integrator 1
3	RCX2	Current Adjustment of Cap. Integrator 2
4	RL	Gain Adjustment of Lowpass Filter
5	LPOUT	Output of Lowpass Filter
6	VM	Reference Voltage 2V
7	GAIN	Gain Adjustment
8	VOUT	Voltage Output
9	VCC	Supply Voltage
10	GND	IC Ground
11	VREF	Reference Voltage 5V
12	COSC	Capacitor of Reference Oscillator
13	CL2	Corner Frequency of Lowpass 2
14	CX2	Integrator Capacitor 2
15	CL1	Corner Frequency of Lowpass 1
16	CX1	Integrator Capacitor 1

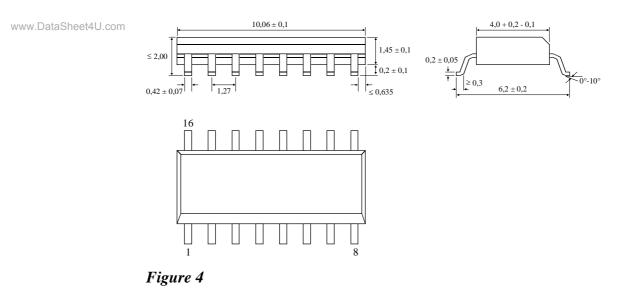
Figure 3

DELIVERY

The CAV414 is available in version:

- 16–Pin–DIL (samples)
- SO 16 (n) (Maximum Power Dissipation $P_D = 300$ mW)
- Dice on 5" blue foil

PACKAGE DIMENSIONS SO16 (n)



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